Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/092,249	WU ET AL.
Examiner	Art Unit
Wen W. Huano	2682

SEARCHED			
Class	Subclass	Date	Examiner
455	422.1	8/30/2004	WH
	426.1		
	433		
	560		
	561		
above	UPDATED	6/15/2005	WH
above	UPDATED	1/3/2006	WH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
& external	ommon core network & n CLM	1/5/2006	WH

SEARCH NO (INCLUDING SEARC)
	DATE	. EXMR
Lee Nguyen (455)	8/30/2004	WH
EAST text search		
IEEE text search		
above UPDATED	6/15/2005	WH
above UPDATED	1/3/2006	WH
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